INTEGRATED CIRCUITS



Product specification IC05 Data Handbook 1996 Jul 01



Philips Semiconductors

74ALS74A

DESCRIPTION

The 74ALS74 is a dual positive edge-triggered D-type flip-flop featuring individual data, clock, set, and reset inputs; also true and complementary outputs. Set (SD) and reset (RD) are asynchronous active-Low inputs and operate independently of the clock input. When set and reset are inactive (High), data at the D input is transferred to the Q and \overline{Q} outputs on the Low-to-High transition of the clock. Data must be stable just one setup time prior to the Low-to-High transition of the clock for predictable operation. Clock triggering occurs at a voltage level and is not directly related to the transition time of the positive-going pulse. Following the hold time interval, data at the D input may be changed without affecting the levels of the output.

| ТҮРЕ | TYPICAL f _{MAX} | TYPICAL SUPPLY CURRENT (TOTAL) |
|----------|--------------------------|--------------------------------------|
| 74ALS74A | 150MHz | 3.0mA |

ORDERING INFORMATION

| | ORDER CODE | | |
|--------------------------------|---|-------------------|--|
| DESCRIPTION | COMMERCIAL RANGE V _{CC} = 5V ±10%, T _{amb} = 0°C to +70°C | DRAWING NUMBER | |
| 14-pin plastic DIP | 74ALS74AN | SOT27-1 | |
| 14-pin plastic SO | 74ALS74AD | SOT108-1 | |
| 14-pin plastic SSOP Type II | 74ALS74ADB | SOT337-1 | |

PIN CONFIGURATION

| RD0 1 | 14 V _{CC} |
|--------------|--------------------|
| D0 2 | 13 RD1 |
| CP0 3 | 12 D1 |
| SD0 4 | 11 CP1 |
| Q0 5 | 10 SD1 |
| <u>Q</u> 0 6 | 9 Q1 |
| GND 7 | 8 Q1 |
| | SF00045 |

INPUT AND OUTPUT LOADING AND FAN-OUT TABLE

| PINS | DESCRIPTION | 74ALS (U.L.) HIGH/LOW | LOAD VALUE HIGH/LOW |
|--------------------------------|-----------------------------------|--------------------------|------------------------|
| D0, D1 | Data inputs | 1.0/2.0 | 20µA/0.2mA |
| CP0, CP1 | Clock inputs (active rising edge) | 1.0/2.0 | 20µA/0.2mA |
| SD0, SD1 | Set inputs (active-Low) | 2.0/4.0 | 40µA/0.4mA |
| RD0, RD1 | Reset inputs (active-Low) | 2.0/4.0 | 40µA/0.4mA |
| Q0, Q1, <u>Q</u> 0, <u>Q</u> 1 | Data outputs | 20/80 | 0.4mA/8mA |

NOTE: One (1.0) ALS unit load is defined as: 20µA in the High state and 0.1mA in the Low state.

LOGIC SYMBOL





74ALS74A

LOGIC DIAGRAM



FUNCTION TABLE

| | INP | JTS | | OUT | PUTS | OPERATING |
|----|-----|------------|---|-----|------|--------------------|
| SD | RD | СР | D | Q | Q | MODE |
| L | Н | Х | Х | Н | L | Asynchronous set |
| Н | L | Х | Х | L | Н | Asynchronous reset |
| L | L | Х | Х | Н | Н | Undetermined* |
| Н | Н | Ŷ | h | Н | L | Load "1" |
| Н | Н | \uparrow | I | L | Н | Load "0" |
| Н | Н | ¢ | Х | NC | NC | Hold |

H = High voltage level

High state must be present one setup time prior to h = Low-to-High clock transition

= Low voltage level

Low state must be present one setup time prior to = Low-to-High clock transition

NC= No change from the previous setup

 $\begin{array}{rcl} X &= & \text{Don't care} \\ \uparrow &= & \text{Low-to-Hig} \\ \uparrow &= & \text{Not Low-to} \\ * &= & \text{Both output} \end{array}$

1

L

= Low-to-High clock transition

Not Low-to-High clock transition

Both outputs will be High while both \overline{SD} and \overline{RD} are Low, = but the output states are unpredictable if \overline{SD} and \overline{RD} go High simultaneously

ABSOLUTE MAXIMUM RATINGS

(Operation beyond the limit set forth in this table may impair the useful life of the device. Unless otherwise noted these limits are over the operating free-air temperature range.)

| SYMBOL | PARAMETER | RATING | UNIT |
|------------------|--|------------------|------|
| V _{CC} | Supply voltage | -0.5 to +7.0 | V |
| V _{IN} | Input voltage | -0.5 to +7.0 | V |
| I _{IN} | Input current | -30 to +5 | mA |
| V _{OUT} | Voltage applied to output in High output state | –0.5 to V_{CC} | V |
| I _{OUT} | Current applied to output in Low output state | 16 | mA |
| T _{amb} | Operating free-air temperature range | 0 to +70 | °C |
| T _{stg} | Storage temperature range | -65 to +150 | °C |

RECOMMENDED OPERATING CONDITIONS

| SYMBOL | PARAMETER | | LIMITS | | | |
|------------------|--------------------------------------|-----|--------|------|------|--|
| STWBOL | PARAMETER | MIN | NOM | MAX | UNIT | |
| V _{CC} | Supply voltage | | 5.0 | 5.5 | V | |
| V _{IH} | High-level input voltage | 2.0 | | | V | |
| VIL | Low-level input voltage | | | 0.8 | V | |
| l _{lk} | Input clamp current | | | -18 | mA | |
| I _{ОН} | High-level output current | | | -0.4 | mA | |
| I _{OL} | Low-level output current | | | 8 | mA | |
| T _{amb} | Operating free-air temperature range | 0 | | +70 | °C | |

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DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

| | | | | | LIMITS | | | |
|---|-------------------------------------|----------|--|-----------------------|---------------------|-------|------|----|
| SYMBOL | YMBOL PARAMETER | | TEST CONDITIC | MIN | TYP ² | MAX | TINU | |
| V _{OH} | High-level output voltage | | $V_{CC} = \pm 10\%,$ $V_{IL} = MAX, V_{IH} = MIN$ | I _{OH} = MAX | V _{CC} – 2 | | | V |
| M | | | $V_{CC} = MIN, V_{IL} = MAX,$ | I _{OL} = 4mA | | 0.25 | 0.40 | V |
| V _{OL} | Low-level output voltage | | V _{IH} = MIN | I _{OL} = 8mA | | 0.35 | 0.50 | V |
| V _{IK} | Input clamp voltage | | $V_{CC} = MIN, I_I = I_{IK}$ | | | -0.73 | -1.5 | V |
| | Input current at maximum input | Dn, CPn | | | | | 0.1 | mA |
| Ι | I _I voltage | | $V_{CC} = MAX, V_I = 7.0V$ | | | 0.2 | mA | |
| | | Dn, CPn | | | | | 20 | μA |
| IIН | High–level input current | SDn, RDn | $V_{CC} = MAX, V_I = 2.7V$ | | | | 40 | μA |
| | | Dn, CPn | | | | -0.2 | mA | |
| I _{IL} Low–level input current | | SDn, RDn | $V_{CC} = MAX, V_I = 0.4V$ | | | | -0.4 | mA |
| Ι _Ο | Output current ³ | | $V_{CC} = MAX, V_O = 2.25V$ | | -30 | | -112 | mA |
| I _{CC} | Supply current (total) ⁴ | | V _{CC} = MAX | | | 3.0 | 4.0 | mA |

NOTES:

1. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.

2. All typical values are at $V_{CC} = 5V$, $T_{amb} = 25^{\circ}C$. 3. The output conditions have been chosen to produce a current that closely approximates one half of the true short–circuit output current, I_{OS} . 4. Measure I_{CC} with the Dn, CPn, and SDn grounded, then with Dn, CPn, and RDn grounded.

AC ELECTRICAL CHARACTERISTICS

| | | | LIM | | |
|--------------------------------------|---|----------------|--|--------------|------|
| SYMBOL | PARAMETER | TEST CONDITION | $\label{eq:Tamb} \begin{array}{l} T_{amb} = 0^\circ C \ to \ +70^\circ C \\ V_{CC} = +5.0V \pm 10\% \\ C_L = 50 p F, \ R_L = 500 \Omega \end{array}$ | | UNIT |
| | | | MIN | MAX | 1 |
| f _{max} | Maximum clock frequency | Waveform 1 | 80 | | MHz |
| t _{PLH} t _{PHL} | Propagation delay CPn to Qn or Qn | Waveform 1 | 3.0 3.0 | 14.0 14.0 | ns |
| t _{PLH} t _{PHL} | Propagation delay SDn or $\overline{R}D$ to Qn or $\overline{Q}n$ | Waveform 2, 3 | 1.0 3.0 | 8.0 10.0 | ns |

AC SETUP REQUIREMENTS

| | | | LIM | | |
|--|--------------------------------------|----------------|---|------|----|
| SYMBOL | PARAMETER | TEST CONDITION | T _{amb} = 0°0 V _{CC} = +5. C _L = 50pF, | UNIT | |
| | | | MIN | MAX | |
| t _{su} (H) t _{su} (L) | Setup time, High or Low Dn to CPn | Waveform 1 | 6.0 6.0 | | ns |
| t _h (H) t _h (L) | Hold time, High or Low Dn to CPn | Waveform 1 | 0.0 0.0 | | ns |
| t _w (H) t _w (L) | CPn Pulse width High or Low | Waveform 1 | 6.0 6.0 | | ns |
| t _w (L) | SDn or RDn Pulse width, Low | Waveform 2, 3 | 6.0 | | ns |
| t _{rec} | Recovery time, SDn or RDn to CPn | Waveform 2, 3 | 6.0 | | ns |

AC WAVEFORMS

For all waveforms, $V_M = 1.3V$.

The shaded areas indicate when the input is permitted to change for predictable output performance.



Waveform 1. Propagation Delay for Data to Output, Data Setup and Hold Times, Clock Width, and Maximum Clock Frequency



Waveform 2. Propagation Delay for Set to Output, Set Pulse Width and Recovery Time for Set to Clock



Waveform 3. Propagation Delay for Reset to Output, Reset Pulse Width and Recovery Time for Reset to Clock

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TEST CIRCUIT AND WAVEFORMS



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| DEFINITIONS | | | | | | |
|---|------------------------|--|--|--|--|--|
| Data Sheet Identification Product Status Definition | | | | | | |
| Objective Specification | Formative or in Design | This data sheet contains the design target or goal specifications for product development. Specifications may change in any manner without notice. | | | | |
| Preliminary Specification Preproduction Product | | This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product. | | | | |
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Dual D-type flip-flop with set and reset

DIP14: plastic dual in-line package; 14 leads (300 mil)

74ALS74A

SOT27-1

SO14: plastic small outline package; 14 leads; body width 3.9 mm

Product specification

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NOTES